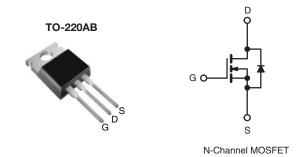


Power MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	400				
$R_{DS(on)}(\Omega)$	V _{GS} = 10 V 0.55				
Q _g (Max.) (nC)	36				
Q _{gs} (nC)	9.9				
Q _{gd} (nC)	16				
Configuration	Single				



FEATURES

• Low Gate Charge Qq Results in Simple Drive



- Improved Gate, Avalanche and Dynamic dV/dt RoHS Ruggedness
- Fully Characterized Capacitance and Avalanche Voltage and Current
- Effective Coss Specified
- Compliant to RoHS Directive 2002/95/EC

APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptable Power Supply
- High Speed Power Switching

TYPICAL SMPS TOPOLOGIES

- Single Transistor Flyback Xfmr. Reset
- Single Transistor Forward Xfmr. Reset (Both for US Line Input Only)

ORDERING INFORMATION			
Package	TO-220AB		
Lead (Pb)-free	IRF740APbF		
Lead (FD)-life	SiHF740A-E3		
SnPb	IRF740A		
SIFD	SiHF740A		

ABSOLUTE MAXIMUM RATINGS (T _C = 25 °C, unless otherwise noted)						
PARAMETER			SYMBOL	LIMIT	UNIT	
Drain-Source Voltage			V_{DS}	400		
Gate-Source Voltage			V_{GS}	± 30	V	
Continuous Drain Current	V -+ 10 V	$T_{\rm C} = 25 ^{\circ}{\rm C}$ $T_{\rm C} = 100 ^{\circ}{\rm C}$		10	A	
	V _{GS} at 10 V	T _C = 100 °C	I _D	6.3		
Pulsed Drain Current ^a			I _{DM}	40		
Linear Derating Factor				1.0	W/°C	
Single Pulse Avalanche Energy ^b			E _{AS}	630	mJ	
Repetitive Avalanche Current ^a			I _{AR}	10	А	
Repetitive Avalanche Energy ^a			E _{AR}	12.5	mJ	
Maximum Power Dissipation $T_C = 25 ^{\circ}C$			P_{D}	125	W	
Peak Diode Recovery dV/dt ^c			dV/dt	5.9	V/ns	
Operating Junction and Storage Temperature Range			T _J , T _{stg}	- 55 to + 150	°C	
Soldering Recommendations (Peak Temperature)	for	10 s		300 ^d	7	
Mounting Torque	6-32 or M3 screw			10	lbf ⋅ in	
Mounting Torque				1.1	N · m	

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11). b. $V_{DD} = 50$ V, starting $T_J = 25$ °C, L = 12.6 mH, $R_g = 25$ Ω , $I_{AS} = 10$ A (see fig. 12). c. $I_{SD} \le 10$ A, $dV/dt \le 330$ A/µs, $V_{DD} \le V_{DS}$, $T_J \le 150$ °C.

- d. 1.6 mm from case.

^{*} Pb containing terminations are not RoHS compliant, exemptions may apply



THERMAL RESISTANCE RATINGS						
PARAMETER	SYMBOL	TYP.	MAX.	UNIT		
Maximum Junction-to-Ambient	R _{thJA}	-	62			
Case-to-Sink, Flat, Greased Surface	R _{thCS}	0.50	-	°C/W		
Maximum Junction-to-Case (Drain)	R _{thJC}	-	1.0			

PARAMETER	SYMBOL	TEST	CONDITIONS	MIN.	TYP.	MAX.	UNIT
Static		•			l	·	
Drain-Source Breakdown Voltage	V _{DS}	$V_{GS} = 0$	V, I _D = 250 μA	400	-	-	V
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	Reference t	to 25 °C, I _D = 1 mA	-	0.48	-	V/°C
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V$	_{GS} , I _D = 250 μA	2.0	-	4.0	V
Gate-Source Leakage	I _{GSS}	V _G	V _{GS} = ± 30 V		-	± 100	nA
Zoro Coto Voltogo Duoin Cuurent	I _{DSS}	$V_{DS} = 40$	V _{DS} = 400 V, V _{GS} = 0 V		-	25	
Zero Gate Voltage Drain Current		V _{DS} = 320 V, V	V _{DS} = 320 V, V _{GS} = 0 V, T _J = 125 °C		-	250	μA
Drain-Source On-State Resistance	R _{DS(on)}	V _{GS} = 10 V	I _D = 6.0 A ^b	-	-	0.55	Ω
Forward Transconductance	9 _{fs}	$V_{DS} = 5$	V _{DS} = 50 V, I _D = 6.0 A ^b		-	-	S
Dynamic							
Input Capacitance	C _{iss}	V	_{GS} = 0 V,	-	1030	-	
Output Capacitance	C _{oss}	V	os = 25 V,	-	170	-	
Reverse Transfer Capacitance	C _{rss}	f = 1.0 MHz, see fig. 5		-	7.7	-	pF
Output Capacitance	C _{oss}	V _{GS} = 0 V, V _{DS} = 1.0 V, f = 1.0 MHz		-	1490	-	
		V _{GS} = 0 V, V _{DS} = 320 V, f = 1.0 MHz		-	52	-	
Effective Output Capacitance	C _{oss}	V _{GS} = 0 V,	V _{GS} = 0 V, V _{DS} = 0 V to 320 V		61	-	
Total Gate Charge	Qg		V _{GS} = 10 V		-	36	nC
Gate-Source Charge	Q _{gs}	V _{GS} = 10 V			-	9.9	
Gate-Drain Charge	Q _{gd}	7	l see ng. e and re	-	-	16	
Turn-On Delay Time	t _{d(on)}				10	-	
Rise Time	t _r	V ₂₂ - 2	00 V, I _D = 10 A,	-	35	-	ns
Turn-Off Delay Time	t _{d(off)}	$R_g = 10 \Omega, R_D$	= 19.5 Ω , see fig. 10 ^b	-	24	-	
Fall Time	t _f	1 1		-	22	-	
Drain-Source Body Diode Characteristic	s						
Continuous Source-Drain Diode Current	I _S	MOSFET symbol showing the integral reverse p - n junction diode		-	-	10	- A
Pulsed Diode Forward Current ^a	I _{SM}			-	-	40	
Body Diode Voltage	V_{SD}	T _J = 25 °C, I _S = 10 A, V _{GS} = 0 V ^b		-	=	2.0	V
Body Diode Reverse Recovery Time	t _{rr}	T _J = 25 °C, I _F = 10 A, dl/dt = 100 A/μs ^b		-	240	360	ns
Body Diode Reverse Recovery Charge	Q _{rr}			-	1.9	2.9	μC
Forward Turn-On Time	t _{on}	Intrinsic turn-	on time is negligible (turn	on is do	minated b	y L _S and	L _D)

Notes

- a. Repetitive rating; pulse width limited by maximum junction temperature (see fig. 11).
- b. Pulse width \leq 300 μ s; duty cycle \leq 2 %.



TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

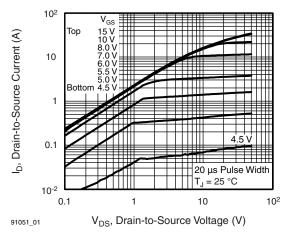


Fig. 1 - Typical Output Characteristics, T_C = 25 °C

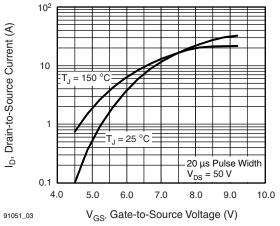


Fig. 3 - Typical Transfer Characteristics

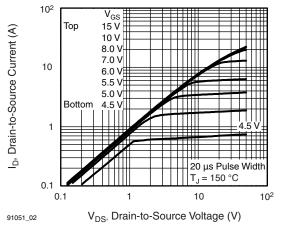


Fig. 2 - Typical Output Characteristics, T_C = 150 °C

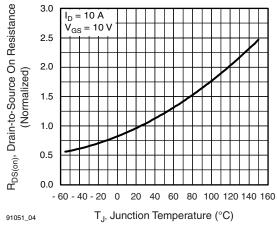


Fig. 4 - Normalized On-Resistance vs. Temperature



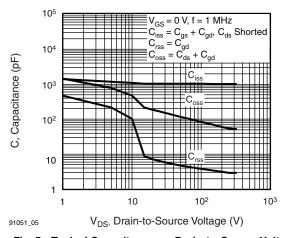


Fig. 5 - Typical Capacitance vs. Drain-to-Source Voltage

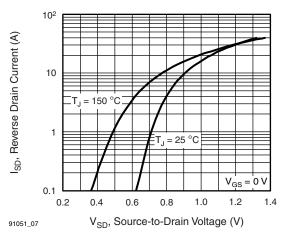


Fig. 7 - Typical Source-Drain Diode Forward Voltage

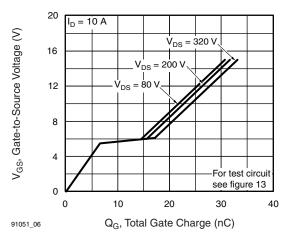


Fig. 6 - Typical Gate Charge vs. Gate-to-Source Voltage

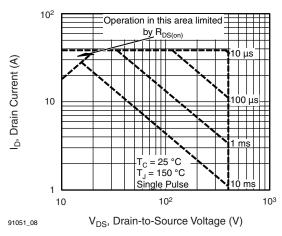


Fig. 8 - Maximum Safe Operating Area





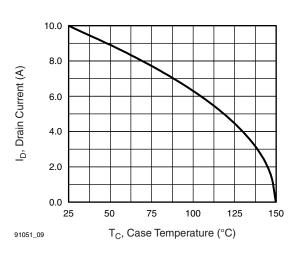


Fig. 9 - Maximum Drain Current vs. Case Temperature

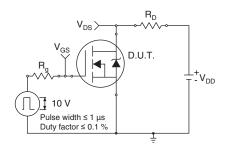


Fig. 10a - Switching Time Test Circuit

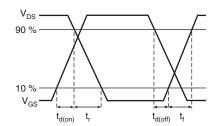


Fig. 10b - Switching Time Waveforms

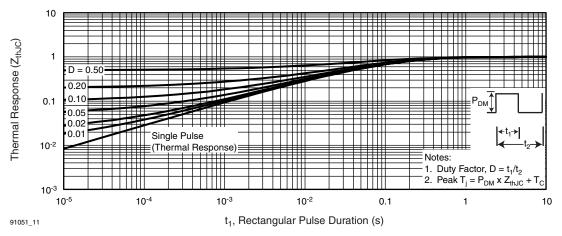


Fig. 11 - Maximum Effective Transient Thermal Impedance, Junction-to-Case

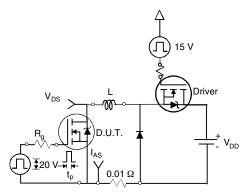


Fig. 12a - Unclamped Inductive Test Circuit

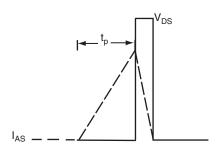


Fig. 12b - Unclamped Inductive Waveforms



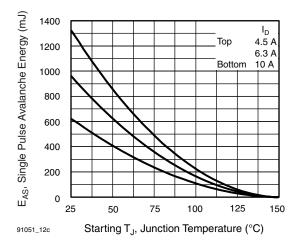


Fig. 12c - Maximum Avalanche Energy vs. Drain Current

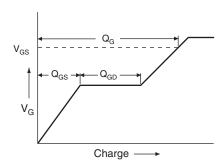


Fig. 13a - Basic Gate Charge Waveform

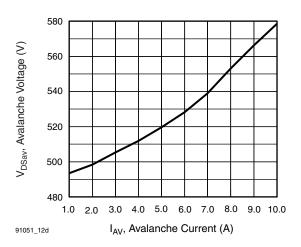


Fig. 12d - Typical Drain-to-Source Voltage vs. **Avalanche Current**

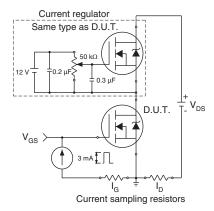
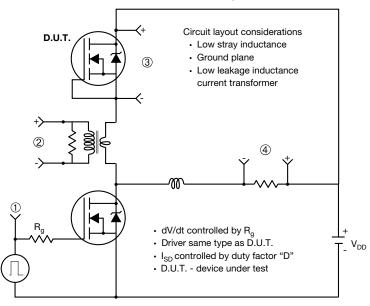


Fig. 13b - Gate Charge Test Circuit



Peak Diode Recovery dV/dt Test Circuit



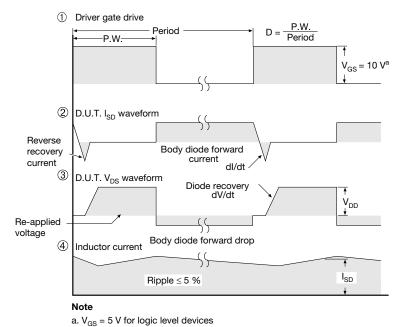
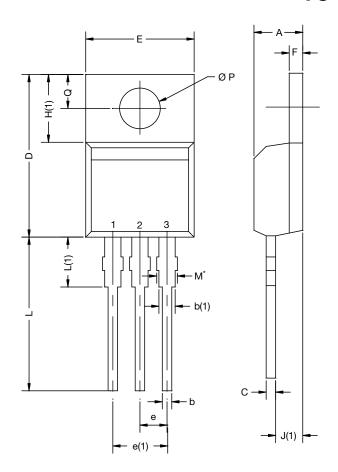


Fig. 14 - For N-Channel

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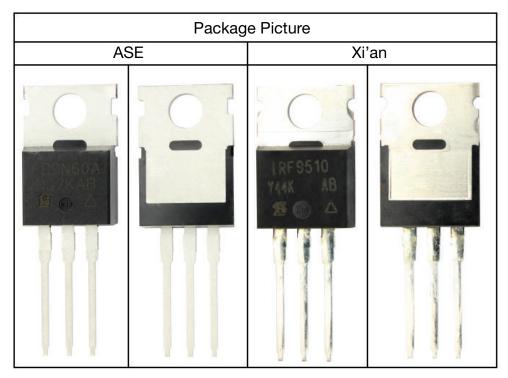
TO-220-1



DIM.	MILLIM	IETERS	INCHES			
DIM.	MIN.	MAX.	MIN.	MAX.		
Α	4.24	4.65	0.167	0.183		
b	0.69	1.02	0.027	0.040		
b(1)	1.14	1.78	0.045	0.070		
С	0.36	0.61	0.014	0.024		
D	14.33	15.85	0.564	0.624		
Е	9.96	10.52	0.392	0.414		
е	2.41	2.67	0.095	0.105		
e(1)	4.88	5.28	0.192	0.208		
F	1.14	1.40	0.045	0.055		
H(1)	6.10	6.71	0.240	0.264		
J(1)	2.41	2.92	0.095	0.115		
L	13.36	14.40	0.526	0.567		
L(1)	3.33	4.04	0.131	0.159		
ØР	3.53	3.94	0.139	0.155		
Q	2.54	3.00	0.100	0.118		
ECN: X15-0364-Rev. C, 14-Dec-15 DWG: 6031						

Note

 M* = 0.052 inches to 0.064 inches (dimension including protrusion), heatsink hole for HVM



Revison: 14-Dec-15 1 Document Number: 66542



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